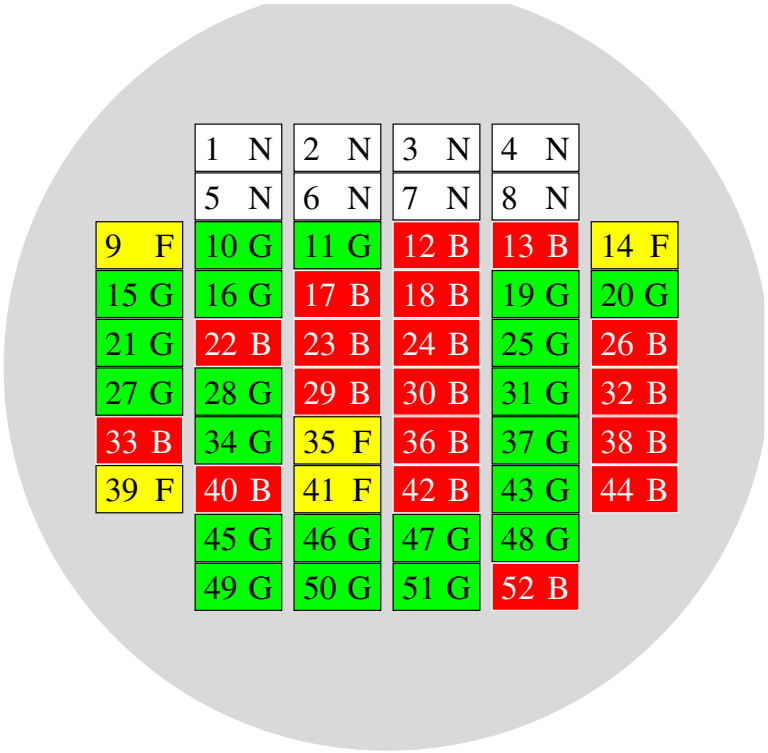
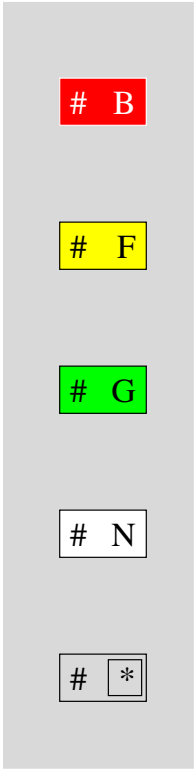
Die quality map for wafer 19 s/n: 21316-02-08

Date: 09/08/98




Bad die

Fair die

Good die

No info

Manually tagged